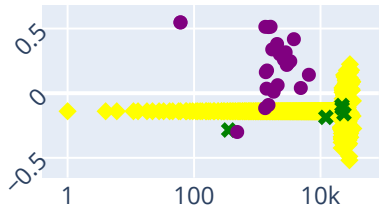
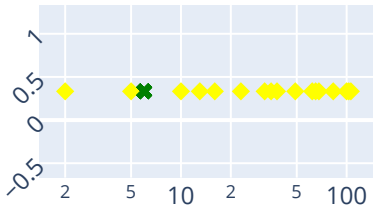


test loss

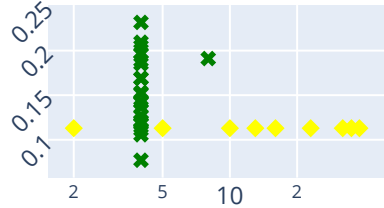
Circuit Recovery (IOI)



tracr-reverse

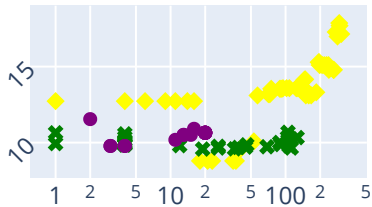


tracr-xproportion

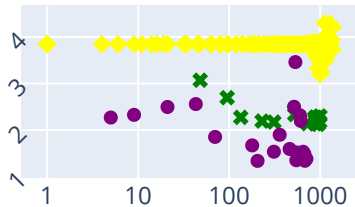


◆ HISP  
✕ SP  
● ACDC

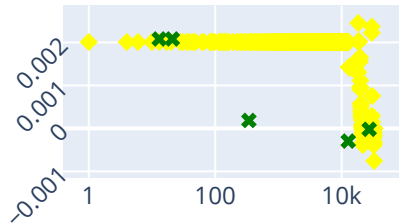
Induction



Docstring



Greater-Than



Number of edges